

# United States Patent and Trademark Office

UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/733,542	12/11/2003	Stephen C. Wardlaw	5169-0011-1-1	7739
50811 75	90 03/06/2006		EXAMINER	
O'SHEA, GETZ & KOSAKOWSKI, P.C. 1500 MAIN ST. SUITE 912 SPRINGFIELD, MA 01115			BHAT, ADITYA S	
			ART UNIT	PAPER NUMBER
			2863	
			DATE MAILED: 03/06/2006	

Please find below and/or attached an Office communication concerning this application or proceeding.

		K	
	Application No.	Applicant(s)	
	10/733,542	WARDLAW ET AL.	
Office Action Summary	Examiner	Art Unit	
	Aditya S. Bhat	2863	
The MAILING DATE of this communication app	pears on the cover sheet with the	correspondence address	
Period for Reply  A SHORTENED STATUTORY PERIOD FOR REPL WHICHEVER IS LONGER, FROM THE MAILING D  - Extensions of time may be available under the provisions of 37 CFR 1.1 after SIX (6) MONTHS from the mailing date of this communication.  - If NO period for reply is specified above, the maximum statutory period - Failure to reply within the set or extended period for reply will, by statute Any reply received by the Office later than three months after the mailin earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION  (36(a). In no event, however, may a reply be ting  will apply and will expire SIX (6) MONTHS from the cause the application to become ABANDONE	N. nely filed the mailing date of this communication. D (35 U.S.C. § 133).	
Status			
Responsive to communication(s) filed on <u>26 €</u> This action is <b>FINAL</b> . 2b)    This     Since this application is in condition for allowal closed in accordance with the practice under €	s action is non-final. ince except for formal matters, pre		
Disposition of Claims			
4)  Claim(s) 1-3,5,8-10,14 and 19-24 is/are pendidal 4a) Of the above claim(s) is/are withdra 5)  Claim(s) is/are allowed.  6)  Claim(s) 1-3,5,8-10,14 and 19-24 is/are reject 7)  Claim(s) is/are objected to.  8)  Claim(s) are subject to restriction and/or control is/are objected.	wn from consideration. ed.		
Application Papers			
9) The specification is objected to by the Examine 10) The drawing(s) filed on 11 December 2003 is/a Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct 11) The oath or declaration is objected to by the E	are: a)⊠ accepted or b)⊡ objec drawing(s) be held in abeyance. Se ction is required if the drawing(s) is ob	e 37 CFR 1.85(a). ojected to. See 37 CFR 1.121(d).	
Priority under 35 U.S.C. § 119			
12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of:  1. Certified copies of the priority documen 2. Certified copies of the priority documen 3. Copies of the certified copies of the priority application from the International Burea * See the attached detailed Office action for a list	ts have been received. ts have been received in Applicat prity documents have been receiv uu (PCT Rule 17.2(a)).	ion No ed in this National Stage	
Attachment/c)			
Attachment(s)  1) Notice of References Cited (PTO-892)  2) Notice of Draftsperson's Patent Drawing Review (PTO-948)  3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08 Paper No(s)/Mail Date 12/16/05.	4) Interview Summan Paper No(s)/Mail D 5) Notice of Informal 6) Other:		

Art Unit: 2863

#### **DETAILED ACTION**

## Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

Claims 1-3, 5, 8-10, 14 and 19-24 are rejected under 35 U.S.C. 102(e) as being anticipated by Okuno et al. (USPN 6,629,060)

With regards to claim 1, Okuno et al. (USPN 6,629,060) teaches a method for providing quality control in an analytical instrument, said method comprising the steps of:

sending one or more quality control specimens to a operator of the analytical instrument; (Col. 4, lines 8-10)

directly or indirectly communicating control data to the analytical instrument, wherein the control data includes characteristic values for the specimens; (Col. 4, lines 8-10)

analyzing the quality control specimen using the analytical instrument and thereby creating instrument analysis data; (Col. 4 lines 10-17),

performing an evaluation within the analytical instrument of the instrument analysis data relative to the control data to determine functional status of the analytical instrument; (col. 4, liens 8-23) and

Art Unit: 2863

providing notice to an operator regarding the functional status of the analytical instrument. (Col. 4, lines 21-23).

With regards to claim 19, Okuno et al. (USPN 6,629,060) teaches a method for providing quality control in an analytical instrument, said method comprising the steps of:

sending one or more quality control specimens to a operator of the analytical instrument (Col. 4, lines 8-10)

directly or indirectly communicating control data to the analytical instrument, wherein the control data includes acceptable operating standards (Col. 4, lines 8-10) analyzing the quality control specimen using the analytical instrument and thereby creating instrument analysis data (Col. 4 lines 10-17);

performing an evaluation within the analytical instrument of the instrument analysis data relative to the control data to determine functional status of the analytical instrument; (col. 4, liens 8-23) and

providing notice to the operator regarding the functional status of the analytical instrument (Col. 4, lines 21-23).

With regards to claim 20, Okuno et al. (USPN 6,629,060) teaches a quality control system for analytical instruments, said system comprising:

one or more quality control specimens, each having one or more predetermined characteristic values and an identifier that can identify the quality control specimen (Col.3 lines 41-45);

Art Unit: 2863

an analytical instrument, having an analyzer for analyzing the one or more quality control specimens and thereby create instrument analysis data that includes one or more sensed characteristic values (Col. 4 lines 10-17) and

means for notifying an operator regarding the functional status of the analytical instrument (Col. 4, lines 21-23).

With regards to claim 24, Okuno et al. (USPN 6,629,060) teaches method for providing quality control in an analytical instrument, said method comprising the steps of:

providing one or more quality control specimens and control data that includes characteristic values for the one or more quality control specimens, to an operator of the analytical instrument; (Col. 4, lines 8-10)

analyzing at least one of the one or more quality control specimens and thereby creating instrument analysis data (Col. 4 lines1-15), and

providing notice to the operator regarding the functional status of the analytical instrument (Col. 3, lines 10-17).

With regards to claim 2, Okuno et al. (USPN 6,629,060) teaches the evaluation being performed without operator input (Col. 4, lines 7-15).

With regards to claim 3, Okuno et al. (USPN 6,629,060) teaches the evaluation is performed using routines preprogrammed within the analytical instrument (Col. 4, lines 25-27).

With regards to claim 5, Okuno et al. (USPN 6,629,060) teaches the step of performing an evaluation within the analytical instrument of includes a comparison of

Art Unit: 2863

the characteristic values for the one or more quality control specimens and one or more characteristic values created within the instrument analysis data (Col. 4, lines 5-23).

With regards to claim 8 Okuno et al. (USPN 6,629,060) teaches the control data is communicated to the analytical instrument from a remote source via an electronic communications connection (Col. 7, lines 4-10).

With regards to claim 9, Okuno et al. (USPN 6,629,060) teaches communicating to the analytical instrument that the quality control specimen is for quality control purposes (Col. 4, lines 7-10).

With regards to claim 10, Okuno et al. (USPN 6,629,060) teaches communicating to the analytical instrument that the quality control specimen is for quality control purposes is performed without operator input (Col. 4, lines 7-15).

With regards to claim 14, Okuno et al. (USPN 6,629,060) teaches the step of providing a preprogrammed schedule for quality control procedures to analytical instrument (Col. 6, lines 3-5).

With regards to claim 19 Okuno et al. (USPN 6,629,060) teaches the step of providing a standardized utilizing quality control procedures (Col. 8, lines 13-15).

With regards to claim 21, Okuno et al. (USPN 6,629,060) teaches the means for performing an evaluation of the analytical instrument within the analytical instrument does not require input from an operator (Col. 4, lines 7-15).

With regards to claim 22, Okuno et al. (USPN 6,629,060) teaches evaluating the sensed characteristic values of the instrument analysis data using the predetermined characteristic values does not require input from an operator (Col.4, lines 8-15).

With regards to claim 23 Okuno et al. (USPN 6,629,060) teaches a standardized identifier displayed with the system that identifies the system as using quality control procedures (Col. 4, lines 9-10).

### Response to Arguments

Applicant's arguments with respect to claims 1-3, 5, 8-10, 14 and 19-24 have been considered but are most in view of the new ground(s) of rejection.

#### Conclusion

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Okuno et al. (USPUB 2004/0019460) teaches a Quality control and support method for analyzer.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Aditya S. Bhat whose telephone number is 571-272-2270. The examiner can normally be reached on M-F 9-5:30.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Barlow can be reached on 571-272-2269. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Application/Control Number: 10/733,542 Page 7

Art Unit: 2863

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Aditya Bhat

February 17, 2006

John Barlow Supervisory Patent Examiner Technology Center 2800